

**Fixed capacitors for use in electronic equipment –****Part 21: Sectional specification: Fixed surface mount multilayer capacitors  
of ceramic dielectric, Class 1****CORRIGENDUM 1**

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**1.5.6  
rated voltage (DC)***Replace, in the note, 'AC' by 'a.c.'*

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**1.5.6  
rated voltage (DC)***Replace, in the title and text, 'DC' by 'd.c.'*

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**1.6.1***Replace, in item b), 'DC' by 'd.c.'*

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**Table 3 – Combination of temperature coefficient and tolerance***Replace the sixth and seventh rows beneath the column headers:*

-220	±30(G)	14,3 / 25,6	11,4 / 20,46	8,58 / 15,3	5,72 / 10,2	-12,5 / -9,50	-16,2 / -12,4	-20,0 / -15,2	-26,3 / -20,0
-330	±60(H)	20,3 / 38,4	16,2 / 30,7	12,2 / 23,0	8,12 / 15,4	-19,5 / – 13,5	-25,4 / -17,6	-31,2 / -21,6	-41,0 / -28,4

*by the following:*

-220	±30(G)	14,3 / 25,6	11,4 / 20,46	8,55 / 15,3	5,70 / 10,2	-12,5 / -9,50	-16,2 / -12,4	-20,0 / -15,2	-26,3 / -20,0
-330	±60(H)	20,3 / 38,4	16,2 / 30,7	12,2 / 23,0	8,10 / 15,4	-19,5 / -13,5	-25,4 / -17,6	-31,2 / -21,6	-41,0 / -28,4

**Table 4 – Fixed sample size test plan for qualification approval – Assessment level EZ**

Replace the column headers by the following:

Group No.	Test	Subclause of this publication	Number of specimens <i>n</i> <sup>e</sup>	Permissible number of non conforming items <i>c</i>
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**Table 5 – Tests schedule for qualification approval**

Replace GROUP 1A by the following:

GROUP 1A	D		See Table 4	
4.15	Robustness of terminations (if applicable)	Test Ua1, Force: 2.5 N Test Ub, Method 1, Force: 2.5 N Number of bends: 1		No visible damage
4.9.1	Initial measurement	Visual examination Capacitance		
4.9	Resistance to soldering heat	See detail specification for the method Recovery: 6 h to 24 h		
4.9.4	Final measurement	Visual examination Capacitance		As in 4.9.4 As in 4.9.4
4.16	Component solvent resistance (if applicable)	Solvent: ... Solvent temperature: ... Method 2 Recovery: ...		See detail specification